

**Notice of References Cited**

Application/Control No.

10/723,863

Applicant(s)/Patent Under  
Reexamination  
CHALECKI ET AL.

Examiner

Tran A. Quoc

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Altova et al. "www. XML Spy.com spy 4 you" Published 05/24/2002 pages 1-565,
	V	XForm 1.0 by W3C Published 07/16/2001 Pages 1-179
	W	
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